

Notice of References Cited	Application/Control No. 10/785,263		Applicant(s)/Patent Under Reexamination YAMAGUCHI ET AL.	
	Examiner Michelle K. Lay		Art Unit 2628	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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*	B	US-2001/0033280 A1	10-2001	Abe et al.	345/419
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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